

Notice of References Cited

Application/Control No.

10/790,226

Applicant(s)/Patent Under
Reexamination
PARK, TAE SOO

Examiner

/James A. Dudek/

Art Unit

2871

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*	B	US-6,144,426	11-2000	Yamazaki et al.	349/95
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NON-PATENT DOCUMENTS

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